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Bib Data Sheet									
SERIAL NUMBER 10/685,542	7-1 1		LASS GROUP ART 324 2829			DC		TTORNEY OCKET NO. 990250B	
APPLICANTS						,			
Shigeyuki Maruyama	, Kawasaki-shi, JAPAN;								
Kazuhiro Tashiro, Kawasaki-shi, JAPAN; Makoto Haseyama, Kawasaki-shi, JAPAN;Futoshi Fukaya, Kawasaki-shi, JAPAN;									
** CONTINUING DATA **********************************									
This application is a DIV of 09/828,221 04/09/2001 PAT 6,661,247 which is a DIV of 09/268,338 03/16/1999 PAT 6,249,135 which is a CIP of 09/009,261 01/20/1998 ABN									
checked MK									
** FOREIGN APPLICATIONS ************************************									
JAPAN 10-263579 09/17/1998									
THE CHECKED FOREIGN FILING LICENSE GRANTED									
IF REQUIRED, FORE ** 01/20/2004	IGN FILING LICENSE GI	KANTEU		mpiismiisimas			a,ameatata		
Foreign Priority claimed 35 USC 119 (a-d) condition	yes ono Met after	Allowance	STATE OR	SHEETS		тот	「AL	INDEPENDENT	
Verified and Acknowledged	xammers Signature In	nitials	COUNTRY JAPAN	1	WING 32	CLA 2	IMS 45	CLAIMS 10	
ADDRESS 23850 ARMSTRONG, KRATZ, QUINTOS, HANSON & BROOKS, LLP 1725 K STREET, NW SUITE 1000 WASHINGTON, DC 20006									
TITLE Semiconductor testing device									
						☐ All Fees			
					1.16 Fees (Filing)				
FILING FEE FEES: Authority has been given in Paper					☐ 1.17 Fees (Processing Ext. of time)				